

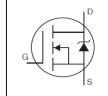
HEXFET[®] Power MOSFET

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Logic Level Gate Drive
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



V _{DSS}	40V
R _{DS(on)} typ.	1.0mΩ
max.	1.4mΩ
D (Silicon Limited)	380A ①
D (Package Limited)	240A



G	D	S
Gate	Drain	Source

Base Dort Number Dockers T		Standar	Standard Pack		
Base Part Number	Package Type	Form	Quantity	Orderable Part Number	
AUIRLS3034-7P	D ² Pak 7 Pin	Tube	50	AUIRLS3034-7P	
AUIRL33034-7P	D Fak / PIII	Tape and Reel Left	800	AUIRLS3034-7TRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	380①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	270①	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	240	A
I _{DM}	Pulsed Drain Current @	1540	
P _D @T _C = 25°C	Maximum Power Dissipation	380	W
	Linear Derating Factor	2.5	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ③	250	mJ
I _{AR}	Avalanche Current ②	See Fig.14,15, 22a, 22b	A
E _{AR}	Repetitive Avalanche Energy ②		mJ
dv/dt	Peak Diode Recovery ④	1.3	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case 90		0.40	°C/W
R _{0JA}	Junction-to-Ambient ®		40	0,00

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*Qualification standards can be found at <u>www.infineon.com</u>



Static @ T_J = 25°C (unless otherwise specified)

	Parameter		Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	V _{GS} = 0V, I _D = 250μA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.035		V/°C	Reference to 25°C, I_D = 5mA \bigcirc
D	Static Drain-to-Source On-Resistance		1.0	1.4	mΩ	V _{GS} = 10V, I _D = 200A ⑤
R _{DS(on)}			1.2	1.7	1115.2	V _{GS} = 4.5V, I _D = 180A ⑤
V _{GS(th)}	Gate Threshold Voltage	1.0		2.5	V	V _{DS} = V _{GS} , I _D = 250μA
gfs	Forward Trans conductance	370			S	V _{DS} = 10V, I _D = 220A
R _G	Gate Resistance		1.9		Ω	
1	Drain to Source Lookage Current			20		V _{DS} = 40V, V _{GS} = 0V
I _{DSS}	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 40V, V_{GS} = 0V$ $V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
1	Gate-to-Source Forward Leakage			100	<u>م</u>	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter Continuous Source Current	Min.	Тур.	max.	Units	Conditions MOSFET symbol
Diode Char			-			0
Coss eff.(TR)	Effective Output Capacitance (Time Related)		3060			V_{GS} = 0V, V_{DS} = 0V to 32V®
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		2520			V_{GS} = 0V, V_{DS} = 0V to 32V \odot
C _{rss}	Reverse Transfer Capacitance		1100		pF	<i>f</i> = 1.0MHz
C _{oss}	Output Capacitance		2030			V _{DS} = 40V
C _{iss}	Input Capacitance		10990			V _{GS} = 0V
t _f	Fall Time		200			V _{GS} = 4.5V⑤
d(off)	Turn-Off Delay Time		94		ns	$R_{G} = 2.7\Omega$
r	Rise Time		590			$I_{\rm D} = 220 {\rm A}$
t _{d(on)}	Turn-On Delay Time		71			V _{DD} = 26V
Q _{sync}	Total Gate Charge Sync. (Qg - Qgd)		49			
Q _{gd}	Gate-to-Drain Charge		71		nC	V _{GS} = 4.5V⑤
Q _{gs}	Gate-to-Source Charge		32			V _{DS} = 20V
\mathbf{Q}_{g}	Total Gate Charge		120	180		I _D = 170A

ls	Continuous Source Current (Body Diode)			380 ①		MOSFET sy showing the	e (t	
I _{SM}	Pulsed Source Current (Body Diode) ②			1540		integral reve p-n junction		
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S$	= 200A,V _{GS} =	= 0V (5
+			46		-	<u>Тј = 25°С</u>	V _{DD} = 34	<
t _{rr}	Reverse Recovery Time		49		ns	<u>T_ = 125°C</u>	I _F = 2204	۹,
0	Reverse Recovery Charge		100		nC	<u>T_ = 25°C</u>	di/dt = 100A	√µs ⑤
Q _{rr}	Reverse Recovery Charge		110			<u>Т_ = 125°C</u>		
I _{RRM}	Reverse Recovery Current		3.7		Α	T _J = 25°C		
t _{on}	Forward Turn-On Time	Intrinsic	turn-or	n time is	negligi	ble (turn-on is	dominated by	L _S +L _D)

Notes:

① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 240A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.

 $\ensuremath{\mathbb Q}$ Repetitive rating; pulse width limited by max. junction temperature.

 $\$ Limited by T_{Jmax}, starting T_J = 25°C, L = 0.010mH, R_G = 25 Ω , I_{AS} = 220A, V_{GS} =10V. Part not recommended for use above this value.

 $\label{eq:ISD} \textcircled{$ I_{SD} \leq 220A, \ di/dt \leq 1240A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^\circ C. $ } }$

(5) Pulse width \leq 400µs; duty cycle \leq 2%.

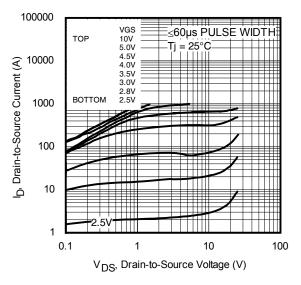
6 Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.

 \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

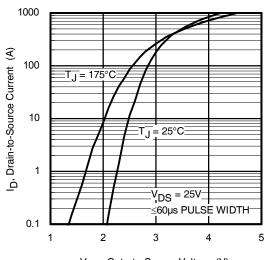
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- (9) R_{θ} is measured at T_J approximately 90°C.

0 R_{0JC} value shown is at time zero









 V_{GS} , Gate-to-Source Voltage (V)

Fig. 3 Typical Transfer Characteristics

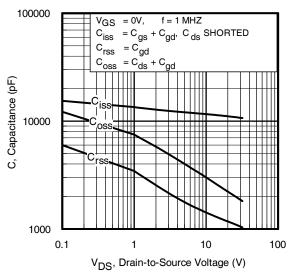


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

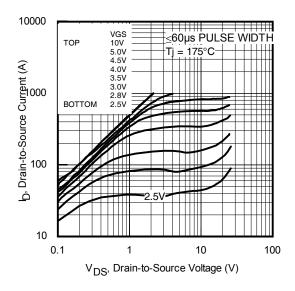
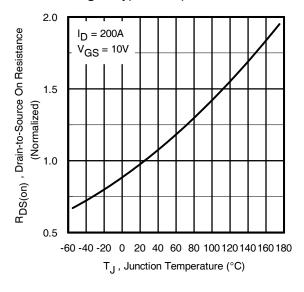


Fig. 2 Typical Output Characteristics





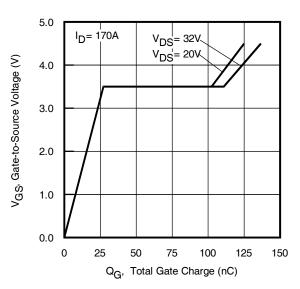


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



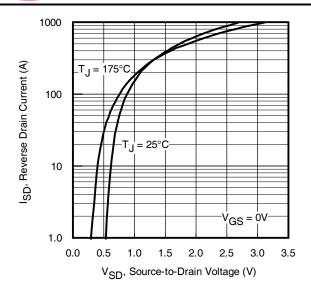


Fig. 7 Typical Source-to-Drain Diode

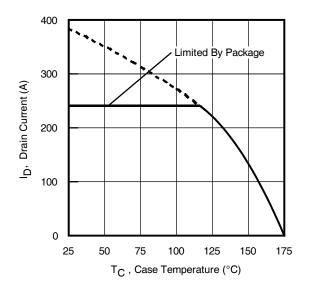


Fig 9. Maximum Drain Current vs. Case Temperature

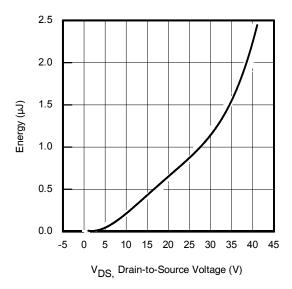


Fig 11. Typical Coss Stored Energy

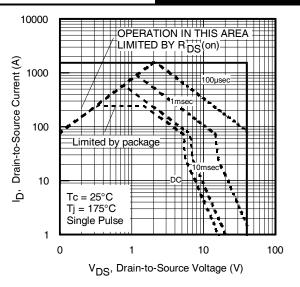


Fig 8. Maximum Safe Operating Area

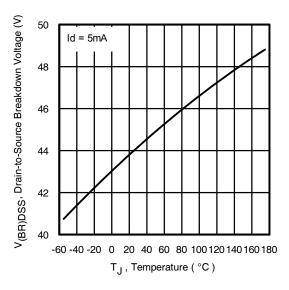


Fig 10. Drain-to-Source Breakdown Voltage

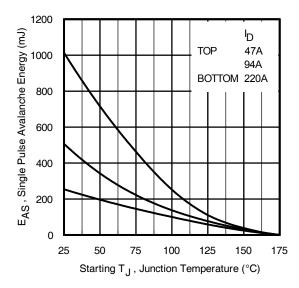


Fig 12. Maximum Avalanche Energy vs. Drain Current

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AUIRLS3034-7P

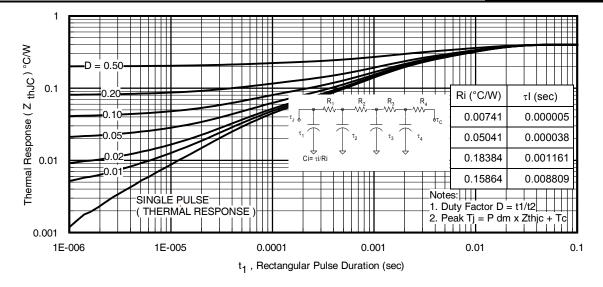


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

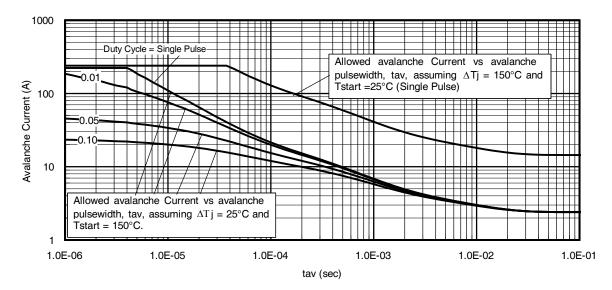
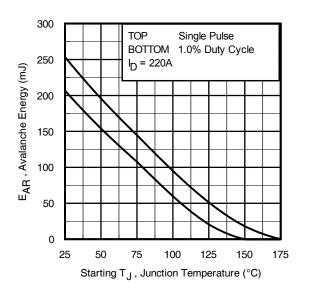


Fig 14. Avalanche Current vs. Pulse width



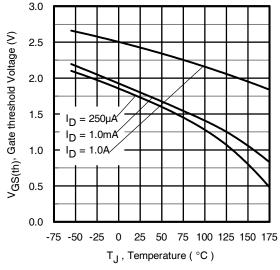


- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of Tjmax. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 13, 14).
 - tav = Average time in avalanche.
 - D = Duty cycle in avalanche = $t_{av} \cdot f$
 - ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \mathsf{P}_{\mathsf{D}\;(\mathsf{ave})} &= \mathsf{1}/\mathsf{2}\;(\;\mathsf{1.3}\cdot\mathsf{BV}\cdot\mathsf{I}_{\mathsf{av}}) = \Delta\mathsf{T}/\;\mathsf{Z}_{\mathsf{thJC}}\\ \mathsf{I}_{\mathsf{av}} &= \mathsf{2}\Delta\mathsf{T}/\;[\mathsf{1.3}\cdot\mathsf{BV}\cdot\mathsf{Z}_{\mathsf{th}}]\\ \mathsf{E}_{\mathsf{AS}\;(\mathsf{AR})} &= \mathsf{P}_{\mathsf{D}\;(\mathsf{ave})}\cdot\mathsf{t}_{\mathsf{av}} \end{split}$$

Fig 15. Maximum Avalanche Energy vs. Temperature







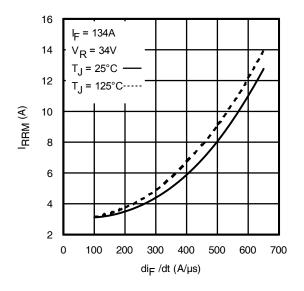
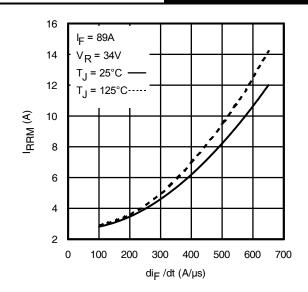
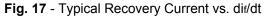


Fig. 18 - Typical Recovery Current vs. dif/dt





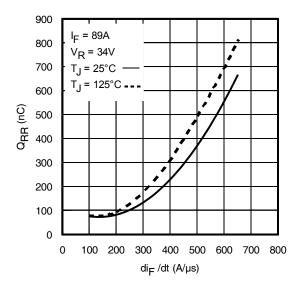


Fig. 19 - Typical Stored Charge vs. dif/dt

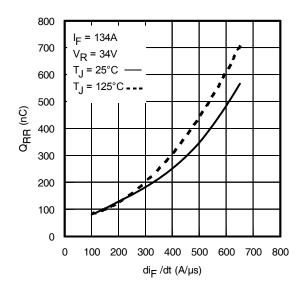
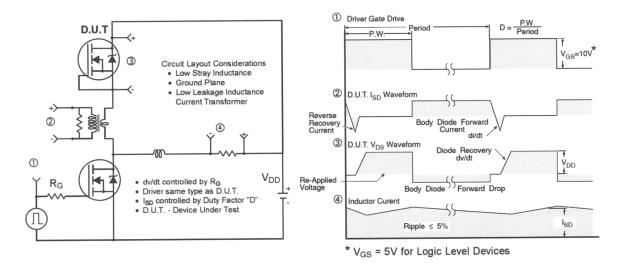
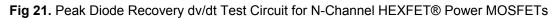


Fig. 20 - Typical Stored Charge vs. dif/dt







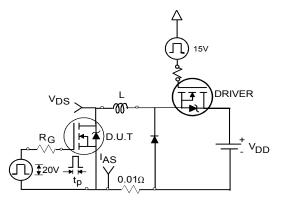


Fig 22a. Unclamped Inductive Test Circuit

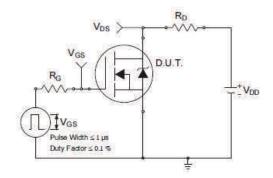


Fig 23a. Switching Time Test Circuit

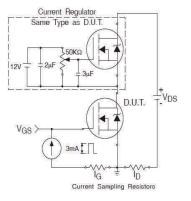


Fig 24a. Gate Charge Test Circuit

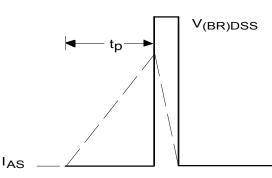
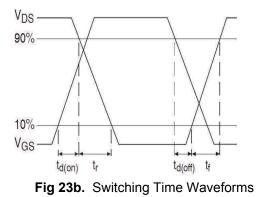


Fig 22b. Unclamped Inductive Waveforms



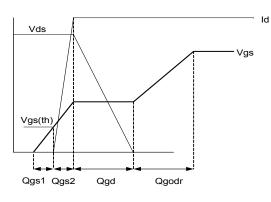
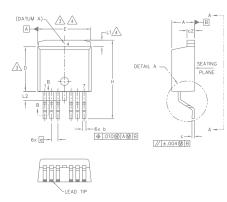
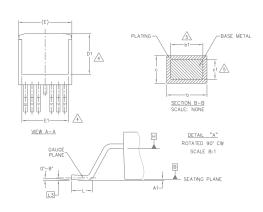


Fig 24b. Gate Charge Waveform



D²Pak - 7 Pin Package Outline (Dimensions are shown in millimeters (inches))





S Y M		N			
В	MILLIM	eters	INC	HES	N O T E S
0 L	MIN.	MAX.	MIN.	MAX.	S
A	4.06	4.83	.160	.190	
A1	_	0.254	-	.010	
b	0.51	0.99	.020	.036	
b1	0.51	0.89	.020	.032	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	7.42	.270	.292	4
E	9.65	10.54	.380	.415	3,4
E1	6.22	8.48	.245	.334	4
е	1.27	BSC	.050	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.68	-	.066	4
L2	-	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

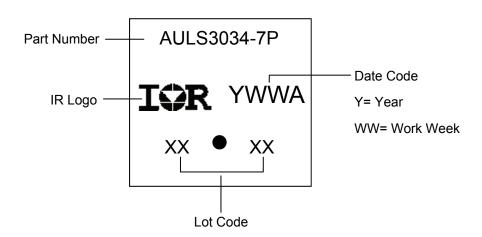
NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263CB. EXCEPT FOR DIMS. E, E1 & D1.

D²Pak - 7 Pin Part Marking Information



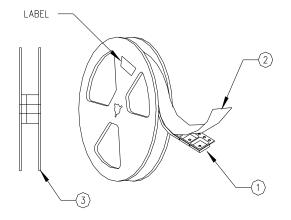
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

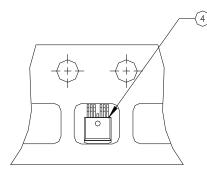
D²Pak - 7 Pin Tape and Reel

NOTES, TAPE & REEL, LABELLING:

- 1. TAPE AND REEL.
 - 1.1 REEL SIZE 13 INCH DIAMETER.
 - 1.2 EACH REEL CONTAINING 800 DEVICES.
 - 1.3 THERE SHALL BE A MINIMUM OF 42 SEALED POCKETS CONTAINED IN THE LEADER AND A MINIMUM OF 15 SEALED POCKETS IN THE TRAILER.
 - 1.4 PEEL STRENGTH MUST CONFORM TO THE SPEC. NO. 71-9667.
 - 1.5 PART ORIENTATION SHALL BE AS SHOWN BELOW.
 - 1.6 REEL MAY CONTAIN A MAXIMUM OF TWO UNIQUE LOT CODE/DATE CODE COMBINATIONS. REWORKED REELS MAY CONTAIN A MAXIMUM OF THREE UNIQUE LOT CODE/DATE CODE COMBINATIONS. HOWEVER, THE LOT CODES AND DATE CODES WITH THEIR RESPECTIVE QUANTITIES SHALL APPEAR ON THE BAR CODE LABEL FOR THE AFFECTED REEL.

- 2. LABELLING (REEL AND SHIPPING BAG).
 - 2.1 CUST. PART NUMBER (BAR CODE): IRFXXXXSTRL-7P
 - 2.2 CUST. PART NUMBER (TEXT CODE): IRFXXXXSTRL-7P
 - 2.3 I.R. PART NUMBER: IRFXXXXSTRL-7P
 - 2.4 QUANTITY:
 - 2.5 VENDOR CODE: IR
 - 2.6 LOT CODE:
 - 2.7 DATE CODE:





Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)				
Qualificat	ion Level	Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the highe Automotive level.				
Moisture	Sensitivity Level	D ² -Pak 7 Pin MSL1				
	Machine Model		Class M4 (+/- 800V) [†]			
	Machine Model	AEC-Q101-002				
ESD	Human Bady Madal		Class H3A (+/- 6000V) [†]			
E9D	Human Body Model	AEC-Q101-001				
	Charmed Davies Medal	Class C5 (+/- 2000V) [†]				
	Charged Device Model	AEC-Q101-005				
RoHS Co	mpliant	Yes				

† Highest passing voltage.

Revision History

Date	Comments
4/2/2014	 Added "Logic Level Gate Drive" bullet in the features section on page 1 Updated part marking on page 8 Updated typo on the fig.19 and fig.20, unit of y-axis from "A" to "nC" on page 6. Updated data sheet with new IR corporate template
11/4/2015	 Updated datasheet with corporate template Corrected ordering table on page 1.

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AUIRLS3034-7TRR AUIRLS3034-7TRL AUIRLS3034-7P